## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | SIGG ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	4	US-2005/0070985	03-2005	Knapp et al.	607/122
	В	US-5,861,023	01-1999	Vachon, David J.	607/121
	O	US-2001/0018607	08-2001	Borgersen et al.	607/121
	۵	US-6,909,919	06-2005	Jain et al.	607/119
	Ш	US-6,358,247	03-2002	Altman et al.	606/41
	F	US-6,856,840	02-2005	Munshi, M. Zafar Amin	607/121
	G	US-			
	π	US-			
	-	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z			_		
	0					
	Р			-		
	α					
	R					
	S					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.